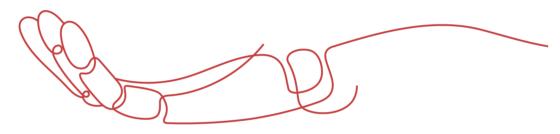


PRODUCT DATA SHEET



To learn more about JGSEMI, please visit our website at



Please note: Please check the JINGAO Semiconductor website to verify the updated device numbers. The most current and up-to-date ordering information can be found at www.jg-semi.cn. Please email any questions regarding the system integration to JINGAO_questions@jgsemi.com.



AP5N04MI

N-Ch 40V Fast Switching MOSFETs

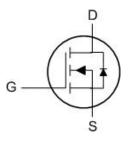
Product Summary

BVDSS	RDSON	ID
40V	19mΩ	7A

- ★ Green Device Available
- ★ Super Low Gate Charge
- ★ Excellent CdV/dt effect decline
- ★ Advanced high cell density Trench technology







Absolute Maximum Ratings (TA=25°C unless otherwise specified)

Symbol	Parameter		Max.	Units
V _{DSS}	Drain-Source Voltage		40	V
V _{GSS}	Gate-Source Voltage		±20	V
	Quating David Quant	T _A = 25℃	7.0	A
Ι _D	Continuous Drain Current	T _A = 100℃	4	A
I _{DM}	Pulsed Drain Current note1		32.8	Α
EAS	Single Pulsed Avalanche Energy note2		13	mJ
PD	Power Dissipation	T _A = 25℃	2.0	W
R _{0JA}	Thermal Resistance, Junction	to Ambient	73	°C/W
T _J , T _{STG}	Operating and Storage Tempe	erature Range	-55 to +150	°C





N-Channel Electrical Characteristics (TJ=25 °C unless otherwise specified)

Symbol	Parameter	Test Condition	Min.	Тур.	Max.	Units
Off Charac	cteristic				1	
V _{(BR)DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V, I _D =250µA	40	-	-	V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =40V, V _{GS} =0V	-	-	1.0	μA
I _{GSS}	Gate to Body Leakage Current	V _{DS} =0V, V _{GS} =±20V	-	-	±100	nA
On Charac	teristics					
V _{GS(th)}	Gate Threshold Voltage	$V_{DS}=V_{GS}$, $I_D=250\mu A$	1.0	1.5	2.5	V
R _{DS(on)}	Static Drain-Source on-Resistance	V _{GS} =10V, I _D =8A	-	19	24	mΩ
	note3	V _{GS} =4.5V, I _D =5A	-	25	35	mΩ
Dynamic C	Characteristics					
Ciss	Input Capacitance	– V _{DS} =20V, V _{GS} =0V, – f=1.0MHz	-	633	-	pF
Coss	Output Capacitance		-	67	-	pF
Crss	Reverse Transfer Capacitance		-	58	-	pF
Qg	Total Gate Charge	- V _{DS} =20V, I _D =8A, - V _{GS} =10V	-	12	-	nC
Q _{gs}	Gate-Source Charge		-	3.2	-	nC
Q_gd	Gate-Drain("Miller") Charge	V _{GS} -10V	-	3.1	-	nC
Switching	Characteristics					
t _{d(on)}	Turn-on Delay Time		-	4	-	ns
tr	Turn-on Rise Time		-	3	-	ns
t _{d(off)}	Turn-off Delay Time	V_{GS} =10V, R_{REN} =3 Ω	-	15	-	ns
t _f	Turn-off Fall Time		-	2	-	ns
Drain-Sou	rce Diode Characteristics and Maxin	num Ratings				
ls	Maximum Continuous Drain to Sourc Current	e Diode Forward	-	-	7	А
I _{SM}	Maximum Pulsed Drain to Source Did	ode Forward Current	-	-	32	Α
V_{SD}	Drain to Source Diode Forward VoltageVGS=0V, IS= 8A		-	-	1.2	V

Notes:1. Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature

2. EAS condition : T_J=25 $^\circ C$,V_DD=20V,V_G=10V,L=0.5mH,Rg=25\Omega,I_{AS}=7.2A

TJ=25℃,VDD=-20V,VG= -10V,L=0.5mH,Rg=25Ω,IAs=-8.4A

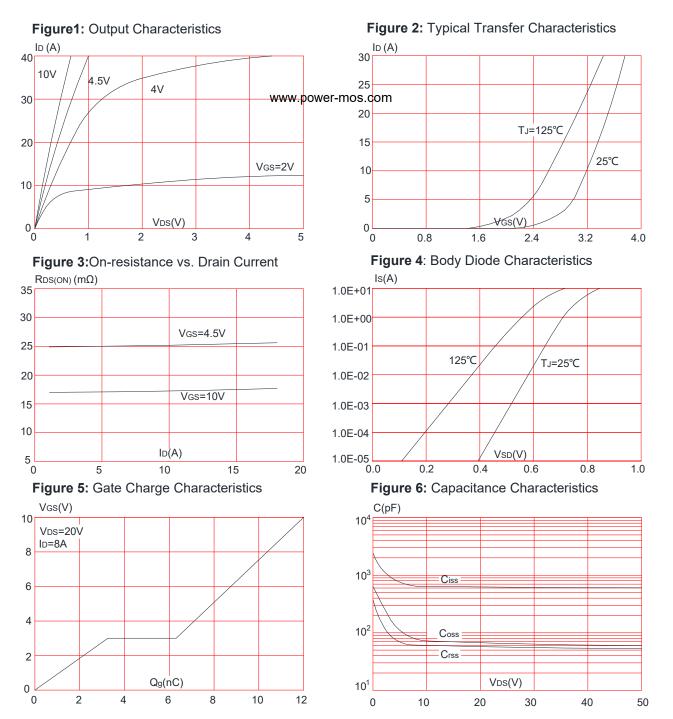
3. Pulse Test: Pulse Width≤300µs, Duty Cycle≤2%

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Typical Performance Characteristics-N





AP5N04MI

Figure 7: Normalized Breakdown Voltage vs. Junction Temperature

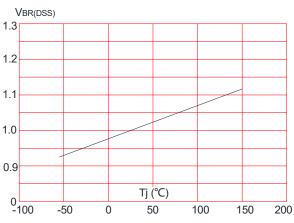
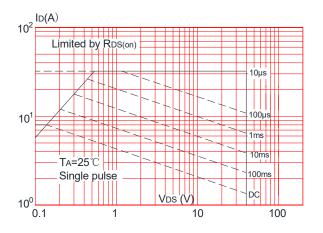
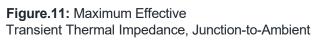
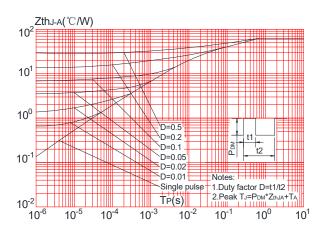


Figure 9: Maximum Safe Operating Area







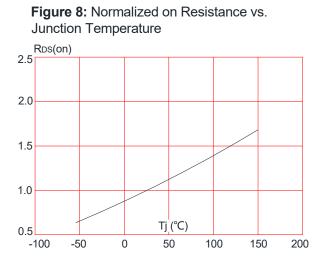
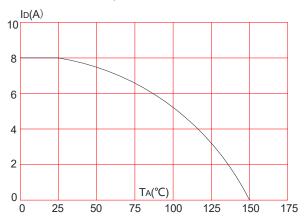


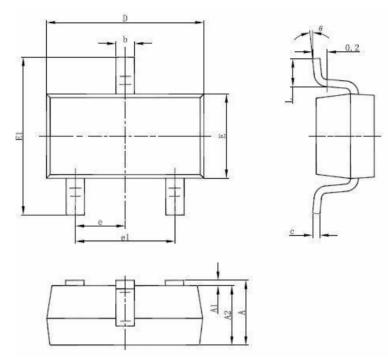
Figure 10: Maximum Continuous Drain Current vs. Ambient Temperature





AP5N04MI

SOT-23-3L Package Information



Symbol	Dimensions In	Millimeters	Dimensions	In Inches
	Min	Max	Min	Max
А	1.050	1.250	0.041	0.049
A1	0.000	0.100	0.000	0.004
A2	1.050	1.150	0.041	0.045
b	0.300	0.500	0.012	0.020
С	0.100	0.200	0.004	0.008
D	2.820	3.020	0.111	0.119
E	1.500	1.700	0.059	0.067
E1	2.650	2.950	0.104	0.116
е	0.950(BSC)		0.037(BSC)	
e1	1.800	2.000	0.071	0.079
L	0.300	0.600	0.012	0.024
θ	0°	8°	0°	8°





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